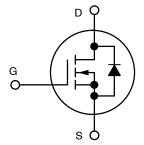
# MOSFET – Power, Single, N-Channel, μCool, UDFN6, 2.0x2.0x0.55 mm 30 V, 10.7 A



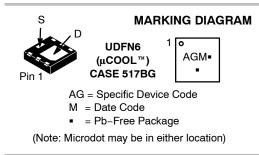
# **ON Semiconductor®**

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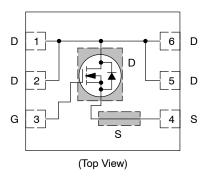
MOSFET						
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX				
	9 mΩ @ 10 V					
30 V	12 mΩ @ 4.5 V	10.7 A				
30 V	15 mΩ @ 3.7 V	10.7 A				
	19 mΩ @ 3.3 V					



#### N-CHANNEL MOSFET



**PIN CONNECTIONS** 



### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

### Features

- Low Profile UDFN 2.0 x 2.0 x 0.55 mm for Board Space Saving with Exposed Drain Pads for Excellent Thermal Conduction
- Ultra Low R<sub>DS(on)</sub> to Reduce Conduction Losses
- Optimized Gate Charge to Reduce Switching Losses
- Low Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- Power Load Switch
- Synch DC–DC Converters
- Wireless Charging Circuit

### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Vo	ltage		V <sub>DSS</sub>	30	V
Gate-to-Source Vol	tage		V <sub>GS</sub>	±20	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	10.7	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		7.7	
	t ≤ 5 s	$T_A = 25^{\circ}C$		15.1	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.54	W
	t ≤ 5 s	T <sub>A</sub> = 25°C		3.1	
Continuous Drain	Steady	T <sub>A</sub> = 25°C	۱ <sub>D</sub>	6.8	А
Current (Note 2)	State	$T_A = 85^{\circ}C$		4.9	
Power Dissipation (	(Note 2)	T <sub>A</sub> = 25°C	PD	0.63	W
Pulsed Drain Curre	nt	t <sub>p</sub> = 10 μs	I <sub>DM</sub>	43	А
MOSFET Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Source Current (Body Diode) (Note 1)			۱ <sub>S</sub>	1.55	А
Lead Temperature (1/8" from case for		g Purposes	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

 Surface-mounted on FR4 board using the minimum recommended pad size, 2 oz. Cu.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient – Steady State (Note 3)	$R_{\thetaJA}$	81	
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{\thetaJA}$	40.5	°C/W
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\thetaJA}$	200	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
Surface-mounted on FR4 board using the minimum recommended pad size, 2 oz. Cu.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V,	I <sub>D</sub> = 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA	a, ref to 25°C		12		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	μA
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V	V <sub>GS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	, I <sub>D</sub> = 250 μA	1.3		2.1	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9.0 A			7.2	9	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 8.0 A			9.3	12	
		V <sub>GS</sub> = 3.7 V	V, I <sub>D</sub> = 5.0 A		10.9	15	
		V <sub>GS</sub> = 3.3 <sup>v</sup>	V, I <sub>D</sub> = 5.0 A		13	19	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 9.0 A			39		S
CHARGES, CAPACITANCES & GATE	RESISTANCE	•			•	•	•
Input Capacitance	Cues				1172		nF

Input Capacitance	C <sub>ISS</sub>		1172	pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V	546	
Reverse Transfer Capacitance	C <sub>RSS</sub>		26	
Total Gate Charge	Q <sub>G(TOT)</sub>		8.4	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 8.0 A	1.1	
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 8.0 A	3.0	
Gate-to-Drain Charge	Q <sub>GD</sub>		2.2	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V; I <sub>D</sub> = 9.0 A	18	nC

### SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		9.4	ns
Rise Time	tr	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 15 V,	15	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 8.0 \text{ A}, \text{ R}_G = 3 \Omega$	14	
Fall Time	t <sub>f</sub>		3.5	

### SWITCHING CHARACTERISTICS, VGS = 10 V (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		6.3	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 15 V,	14	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 9.0 \text{ A}, \text{ R}_G = 3 \Omega$	18	
Fall Time	t <sub>f</sub>		2.4	

5. Pulse Test: pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2%.

6. Switching characteristics are independent of operating junction temperatures.

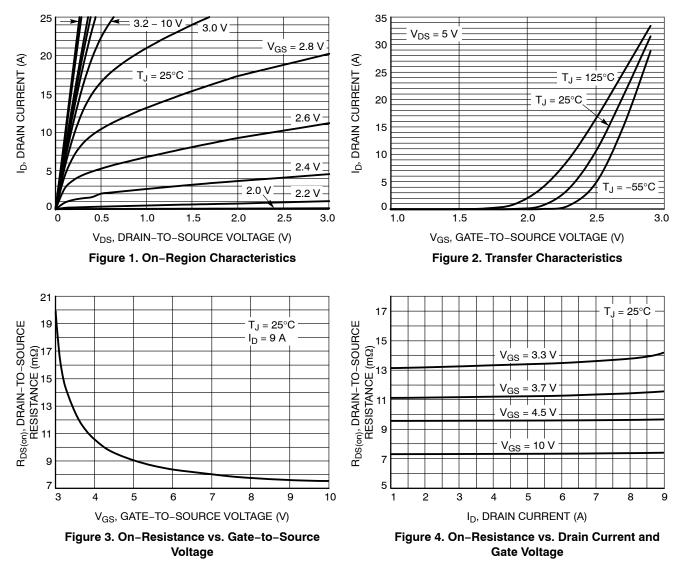
# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units	
DRAIN-SOURCE DIODE CHARACTER	DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.5 A	$T_J = 25^{\circ}C$		0.72	1.1	V	
			T <sub>J</sub> = 125°C		0.52			
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/µs, I <sub>S</sub> = 1.5 A			29		ns	
Charge Time	t <sub>a</sub>				14.1			
Discharge Time	t <sub>b</sub>				14.9			
Reverse Recovery Charge	Q <sub>RR</sub>				20		nC	

5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

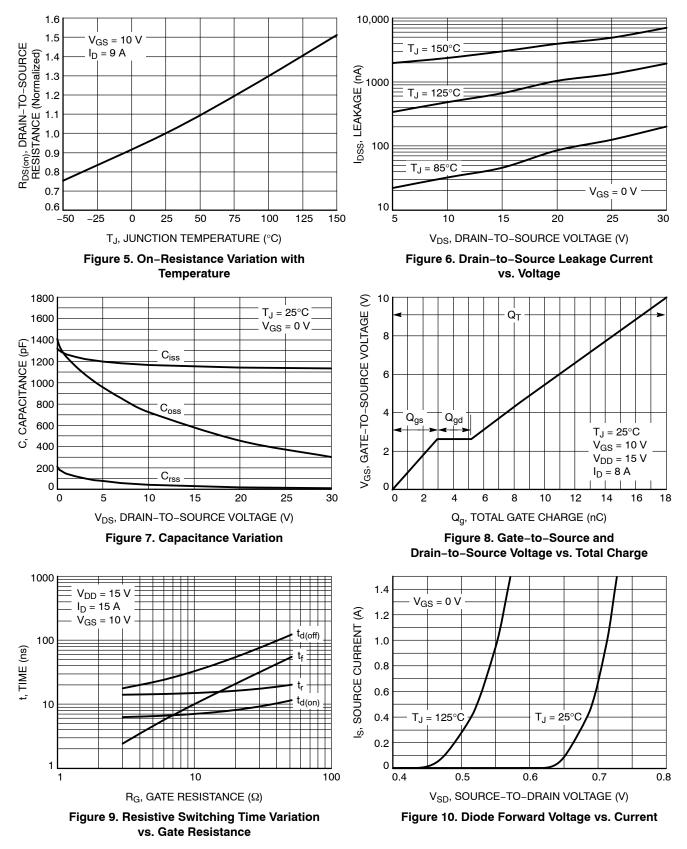
6. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

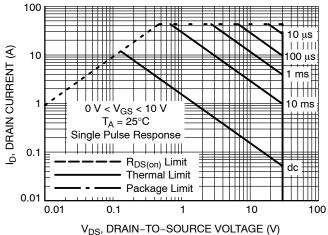


# **TYPICAL CHARACTERISTICS**

# **TYPICAL CHARACTERISTICS**



### **TYPICAL CHARACTERISTICS**



V<sub>DS</sub>, DRAIN-10-300RCE VOLIAGE (V)

Figure 11. Maximum Rated Forward Biased Safe Operating Area

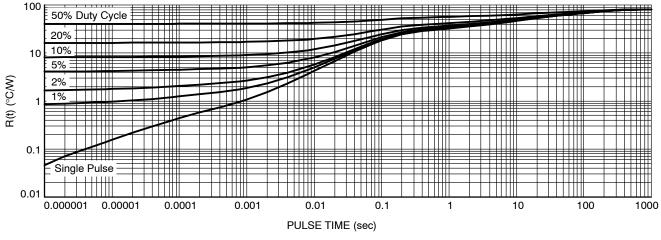


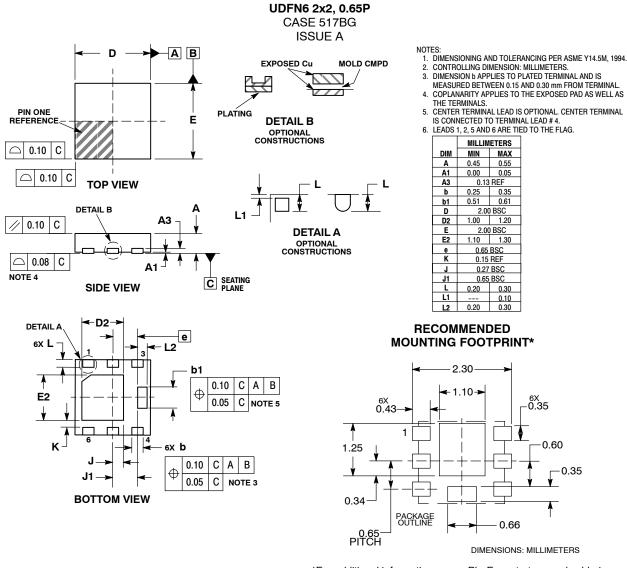
Figure 12. Thermal Response

### **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLUS4C12NTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS4C12NTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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